

March 2010

FDMC4435BZ

P-Channel Power Trench[®] MOSFET -30 V, -18 A, 20 m Ω

Features

- Max $r_{DS(on)}$ = 20 m Ω at V_{GS} = -10 V, I_D = -8.5 A
- Max $r_{DS(on)}$ = 37 m Ω at V_{GS} = -4.5 V, I_D = -6.3 A
- Extended V_{GSS} range (-25 V) for battery applications
- High performance trench technology for extremely low r_{DS(on)}
- High power and current handling capability
- HBM ESD protection level >7 kV typical (Note 4)
- 100% UIL Tested
- Termination is Lead-free and RoHS Compliant

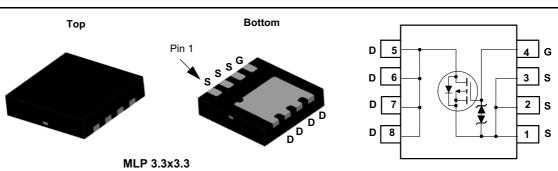
General Description

This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Applications

- High side in DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook





MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V_{DS}	Drain to Source Voltage			-30	V
V_{GS}	Gate to Source Voltage			±25	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		-18	
I _D	-Continuous (Silicon limited) T _C = 25 °C			-32	
	-Continuous	T _A = 25 °C	(Note 1a)	-8.5	Α
	-Pulsed			-50	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	24	mJ
Б	Power Dissipation $T_C = 25 ^{\circ}C$			31	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.3	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC4435BZ	FDMC4435BZ	MLP 3.3X3.3	13 "	12 mm	3000 units

Electrical Characteristics $T_J = 25 \, ^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	acteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu\text{A}, V_{GS} = 0 \text{V}$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		- 22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -24 V, V _{GS} = 0 V,			-1 -100	μΑ
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±25 V, V _{DS} = 0 V			±10	μΑ

On Characteristics

Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250 \mu A$	-1.0	-1.9	-3.0	V
Gate to Source Threshold Voltage Temperature Coefficient	I _D = -250 μA, referenced to 25 °C		5.3		mV/°C
r _{DS(on)} Static Drain to Source On Resistance	$V_{GS} = -10 \text{ V}, I_D = -8.5 \text{ A}$		15	20	
	$V_{GS} = -4.5 \text{ V}, I_D = -6.3 \text{ A}$		23	37	mΩ
Static Drain to Source Off Nesistance	$V_{GS} = -10 \text{ V}, I_D = -8.5 \text{ A},$ $T_J = 125 ^{\circ}\text{C}$		21	28	11122
Forward Transconductance	$V_{DD} = -5 \text{ V}, I_D = -8.5 \text{ A}$		24		S
	Gate to Source Threshold Voltage Temperature Coefficient Static Drain to Source On Resistance	Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250 \ \mu\text{A}, \text{ referenced to } 25 \ ^{\circ}\text{C}$ $V_{GS} = -10 \ \text{V}, \ I_D = -8.5 \ \text{A}$ $V_{GS} = -4.5 \ \text{V}, \ I_D = -6.3 \ \text{A}$ $V_{GS} = -10 \ \text{V}, \ I_D = -8.5 \ \text{A}, \ I_J = 125 \ ^{\circ}\text{C}$	Gate to Source Threshold Voltage Temperature Coefficient $I_D = -250 \ \mu\text{A, referenced to } 25 \ ^{\circ}\text{C}$ Static Drain to Source On Resistance $\frac{V_{GS} = -10 \ \text{V, } \ I_D = -8.5 \ \text{A}}{V_{GS} = -10 \ \text{V, } \ I_D = -8.5 \ \text{A}}$ $\frac{V_{GS} = -10 \ \text{V, } \ I_D = -8.5 \ \text{A}}{I_J = 125 \ ^{\circ}\text{C}}$		

Dynamic Characteristics

C _{iss}	Input Capacitance	V - 45 V V - 0 V	1540	2045	pF
C _{oss}	Output Capacitance	V _{DS} = -15 V, V _{GS} = 0 V, ————————————————————————————————————	295	395	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 1/11/12	260	385	pF
R_{α}	Gate Resistance	f = 1 MHz	5		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time				10	20	ns
t _r	Rise Time	V _{DD} = -15 V, I _D = -8.	V _{DD} = -15 V, I _D = -8.5 A,		6	12	ns
t _{d(off)}	Turn-Off Delay Time	V _{GS} = -10 V, R _{GEN} =	V_{GS} = -10 V, R_{GEN} = 6 Ω		34	55	ns
t _f	Fall Time				20	36	ns
Q_q	Total Gate Charge	$V_{GS} = 0 V \text{ to -} 10 V$			33	46	nC
Q_g	Total Gate Charge	V _{GS} = 0 V to -4.5 V	V _{DD} = -15 V,		17	24	nC
Q_{gs}	Gate to Source Charge		$I_D = -8.5 A$		5		nC
Q _{gd}	Gate to Drain "Miller" Charge				9		nC

Drain-Source Diode Characteristics

V	Source to Drain Diade Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -8.5A$ (Note 2)	0.92	1.5	\/
V _{SD} Source to Drain Diode Forward Voltage		$V_{GS} = 0 \text{ V}, I_{S} = -1.9 \text{ A}$ (Note 2)	0.75	1.2	٧
t _{rr}	Reverse Recovery Time	L = 0.5 A di/dt = 100 A/va	22		ns
Q _{rr}	Reverse Recovery Charge	I _F = -8.5 A, di/dt = 100 A/μs	11		nC
NOTES:	'	-	* *		*

^{1.} $R_{\theta,JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0 %.
- 3. E_{AS} of 24 mJ is based on starting $T_J = 25$ °C, L = 1 mH, I_{AS} = -7 A, $V_{DD} = -27$ V, $V_{GS} = -10$ V. 100% test at L = 3 mH, I_{AS} = -4 A.
- 4. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied.

Typical Characteristics T_J = 25°C unless otherwise noted

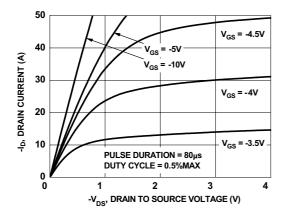


Figure 1. On-Region Characteristics

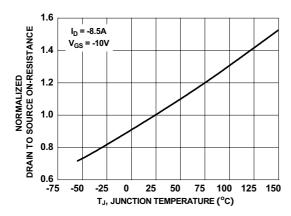


Figure 3. Normalized On-Resistance vs Junction Temperature

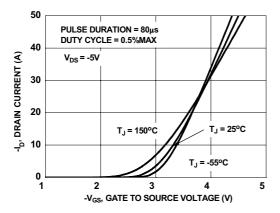


Figure 5. Transfer Characteristics

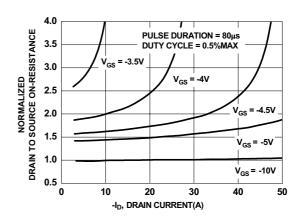


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

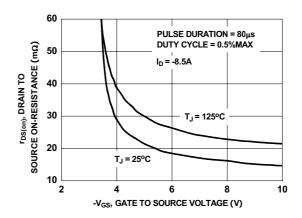


Figure 4. On-Resistance vs Gate to Source Voltage

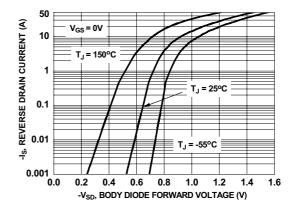


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

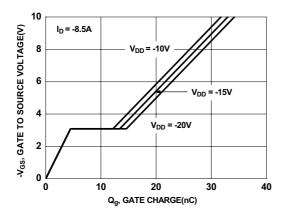


Figure 7. Gate Charge Characteristics

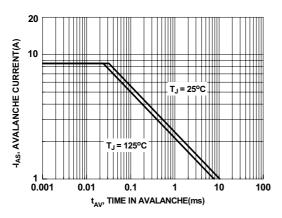


Figure 9. Unclamped Inductive Switching Capability

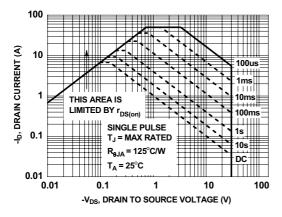


Figure 11. Forward Bias Safe Operating Area

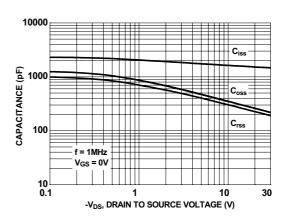


Figure 8. Capacitance vs Drain to Source Voltage

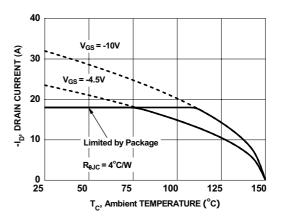


Figure 10. Maximum Continuous Drain Current vs Case Temperature

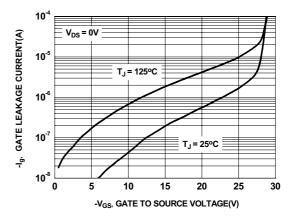


Figure 12. Igss vs Vgss

Typical Characteristics T_J = 25°C unless otherwise noted

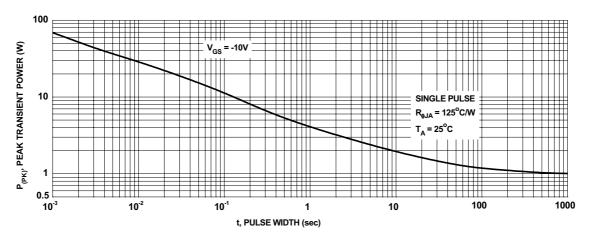


Figure 13. Single Pulse Maximum Power Dissipation

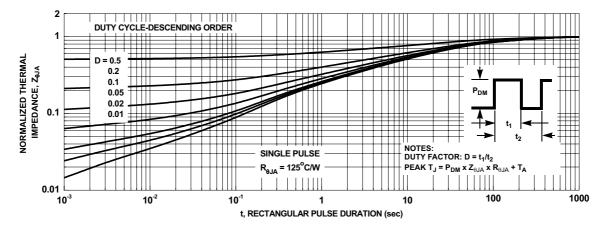
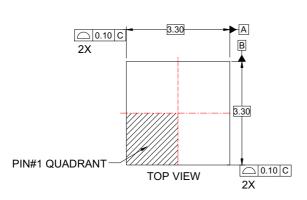
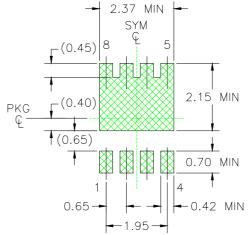
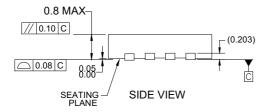


Figure 14. Transient Thermal Response Curve

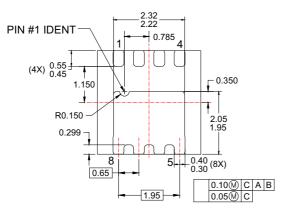
Dimensional Outline and Pad Layout











BOTTOM VIEW

NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. DRAWING FILE NAME: MLP08SREVA
- E. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY





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